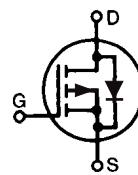


Standard Power MOSFET

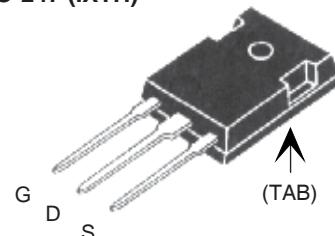
IXTH50P10
IXTT50P10

V_{DSS} = - 100V
I_{D25} = - 50A
R_{DS(on)} ≤ 55mΩ

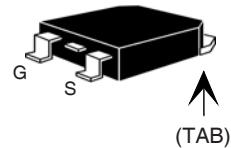
P-Channel Enhancement Mode
Avalanche Rated



TO-247 (IXTH)



TO-268 (IXTT)



G = Gate D = Drain
S = Source TAB = Drain

Symbol	Test Conditions	Maximum Ratings	
V _{DSS}	T _J = 25°C to 150°C	-100	V
V _{DGR}	T _J = 25°C to 150°C, R _{GS} = 1MΩ	-100	V
V _{GSS}	Continuous	±20	V
V _{GSM}	Transient	±30	V
I _{D25}	T _C = 25°C	- 50	A
I _{DM}	T _C = 25°C, pulse width limited by T _{JM}	- 200	A
I _A	T _C = 25°C	- 50	A
E _{AS}	T _C = 25°C	30	mJ
P _D	T _C = 25°C	300	W
T _J		- 55 ... +150	°C
T _{JM}		150	°C
T _{stg}		- 55 ... +150	°C
T _L	1.6mm (0.062 in.) from case for 10s	300	°C
T _{SOLD}	Plastic body for 10s	260	°C
M _d	Mounting torque (TO-247)	1.13 / 10	Nm/lb.in.
Weight	TO-247	6	g
	TO-268	5	g

Features

- International standard packages JEDEC TO-247 AD
- Low R_{DS(ON)} HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance (< 5nH)
 - easy to drive and to protect

Applications

- High side switching
- Push-pull amplifiers
- DC Choppers
- Automatic test equipment

Advantages

- Easy to mount with 1 screw (isolated mounting screw hole)
- Space savings
- High power density

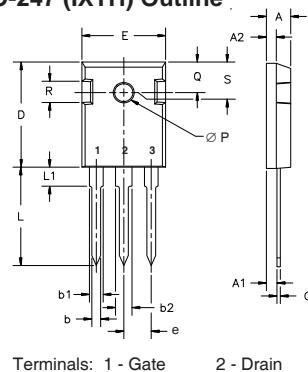
Symbol	Test Conditions	Characteristic Values		
	(T _J = 25°C, unless otherwise specified)	Min.	Typ.	Max.
BV _{DSS}	V _{GS} = 0V, I _D = - 250 μA	-100		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250μA	- 3.0		- 5.0 V
I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100 mA
I _{DSS}	V _{DS} = 0.8 • V _{DSS} V _{GS} = 0V			- 25 μA -1 mA
R _{DS(on)}	V _{GS} = -10V, I _D = 0.5 • I _{D25} , Note 1			55 mΩ

Symbol	Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
g_{fs}	$V_{DS} = -10\text{V}$, $I_D = 0.5 \cdot I_{D25}$, Note 1	13	22	S
C_{iss}		4350		pF
C_{oss}		1505		pF
C_{rss}		733		pF
$t_{d(on)}$	Resistive Switching Times $V_{GS} = -10\text{V}$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 0.5 \cdot I_{D25}$ $R_G = 4.7\Omega$ (External)	46		ns
t_r		39		ns
$t_{d(off)}$		86		ns
t_f		38		ns
$Q_{g(on)}$		140		nC
Q_{gs}		25		nC
Q_{gd}		85		nC
R_{thJC}			0.42 $^\circ\text{C}/\text{W}$	
R_{thCS}		0.25		$^\circ\text{C}/\text{W}$

Source-Drain Diode

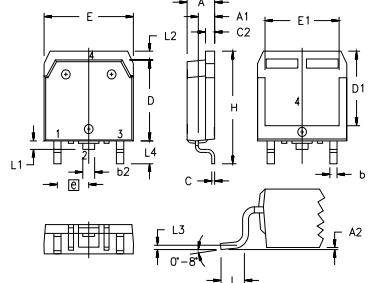
Symbol	Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
I_s	$V_{GS} = 0\text{V}$			- 50 A
I_{SM}	Repetitive, pulse width limited by T_{JM}			- 200 A
V_{SD}	$I_F = - 25\text{A}$, $V_{GS} = 0\text{V}$, Note 1			- 3.0 V
t_{rr}	$I_F = - 25\text{A}$, $dI/dt = - 100\text{A}/\mu\text{s}$, $V_R = - 50\text{V}$, $V_{GS} = 0\text{V}$	180		ns

Note 1: Pulse test, $t \leq 300\mu\text{s}$; duty cycle, $d \leq 2\%$.

TO-247 (IXTH) Outline


Terminals: 1 - Gate 2 - Drain

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.7	5.3	.185	.209
A ₁	2.2	2.54	.087	.102
A ₂	2.2	2.6	.059	.098
b	1.0	1.4	.040	.055
b ₁	1.65	2.13	.065	.084
b ₂	2.87	3.12	.113	.123
C	.4	.8	.016	.031
D	20.80	21.46	.819	.845
E	15.75	16.26	.610	.640
e	5.20	5.72	.205	.225
L	19.81	20.32	.780	.800
L ₁		4.50		.177
$\emptyset P$	3.55	3.65	.140	.144
Q	5.89	6.40	.232	.252
R	4.32	5.49	.170	.216

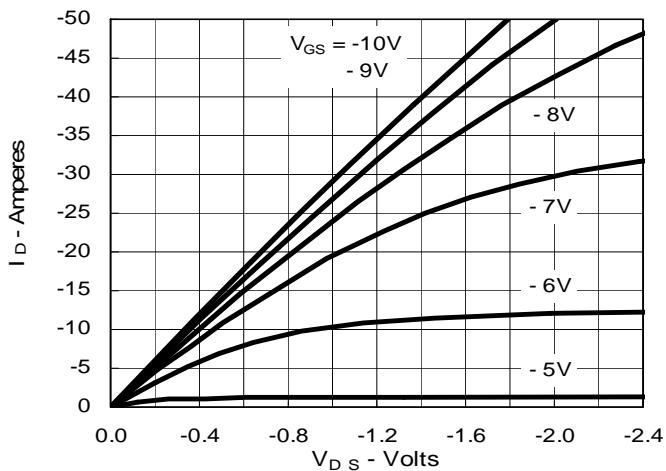
TO-268 (IXTT) Outline


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A ₁	.106	.114	2.70	2.90
A ₂	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b ₂	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C ₂	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D ₁	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E ₁	.524	.535	13.30	13.60
e	.215 BSC		5.45 BSC	
H	.736	.752	18.70	19.10
L	.094	.106	2.40	2.70
L ₁	.047	.055	1.20	1.40
L ₂	.039	.045	1.00	1.15
L ₃	.010 BSC		0.25 BSC	
L ₄	.150	.161	3.80	4.10

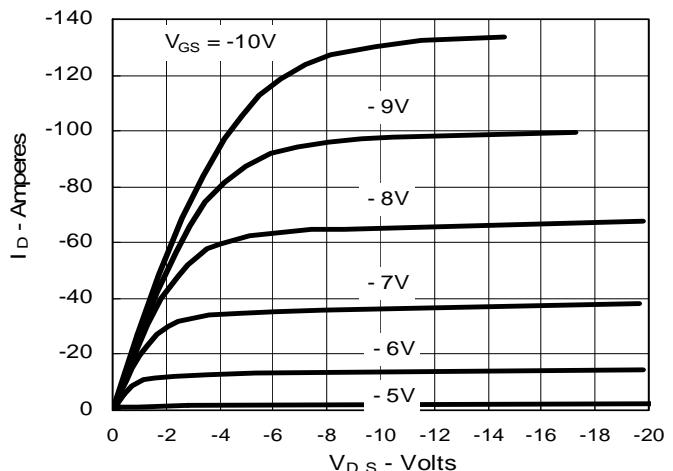
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

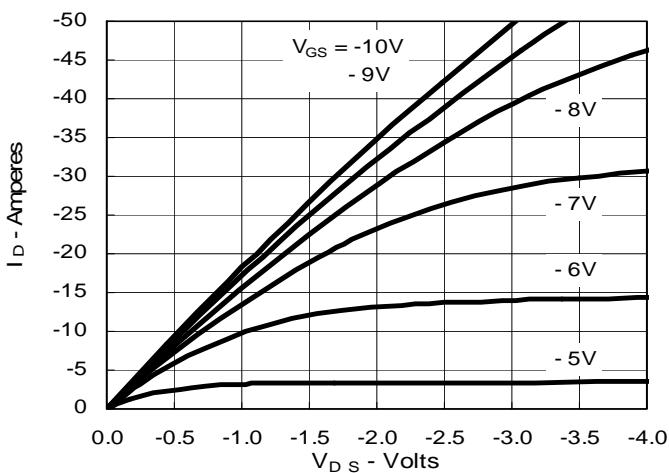
**Fig. 1. Output Characteristics
@ 25°C**



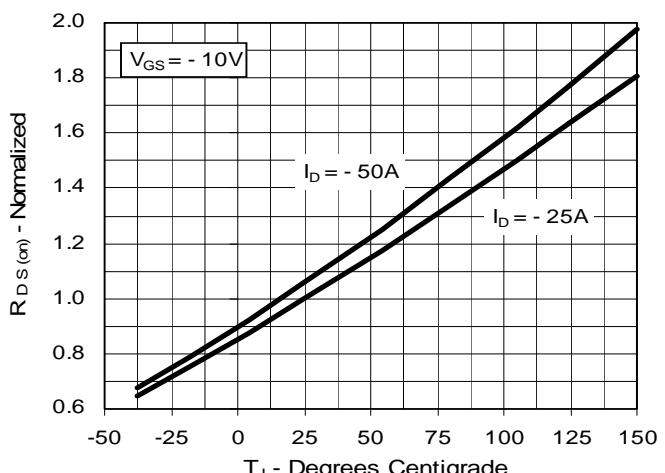
**Fig. 2. Extended Output Characteristics
@ 25°C**



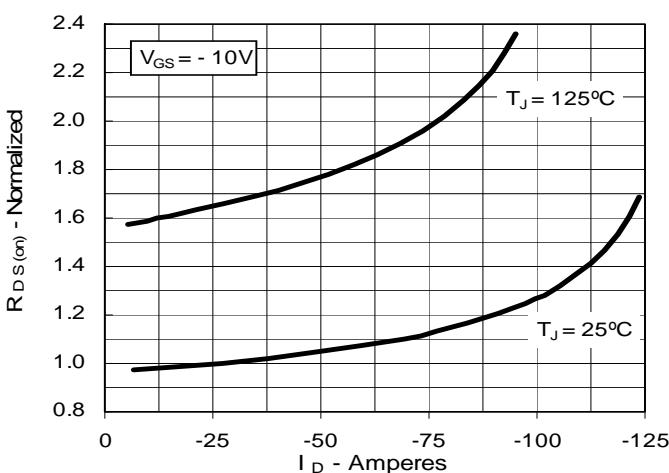
**Fig. 3. Output Characteristics
@ 125°C**



**Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value
vs. Junction Temperature**



**Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25}
Value vs. I_D**



**Fig. 6. Drain Current vs. Case
Temperature**

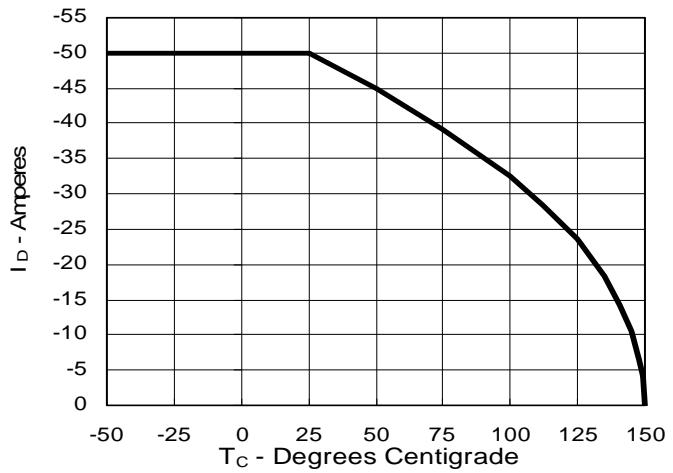


Fig. 7. Input Admittance

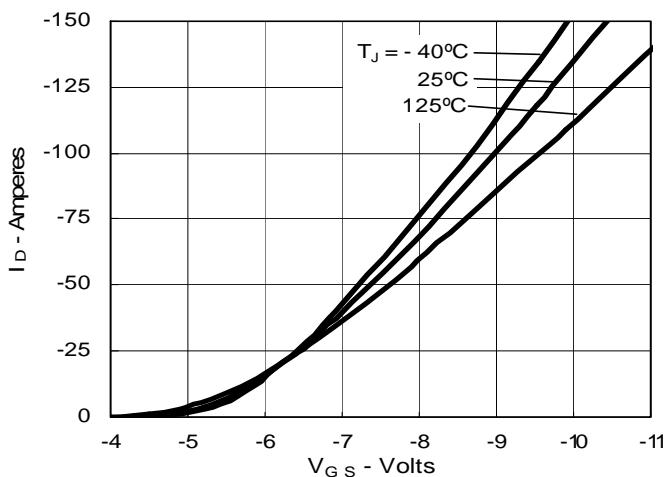


Fig. 9. Source Current vs. Source-To-Drain Voltage

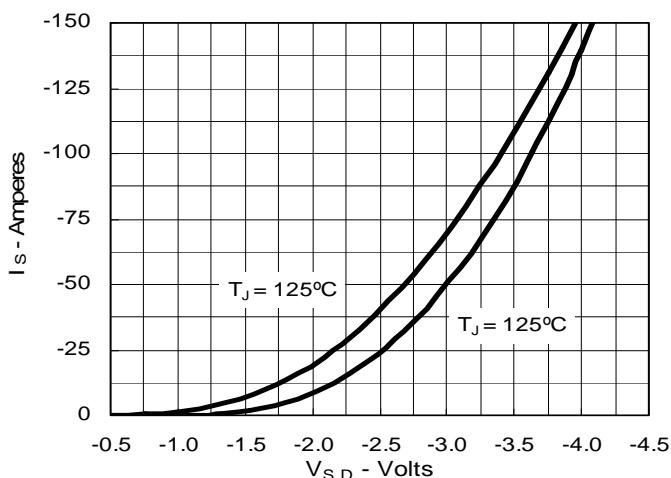


Fig. 11. Capacitance

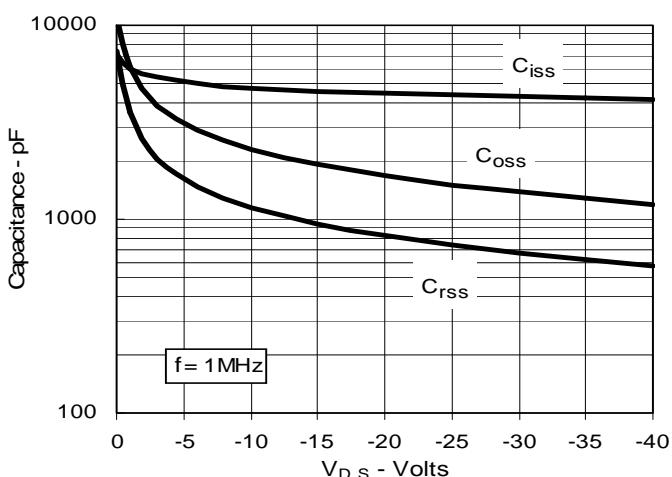


Fig. 8. Transconductance

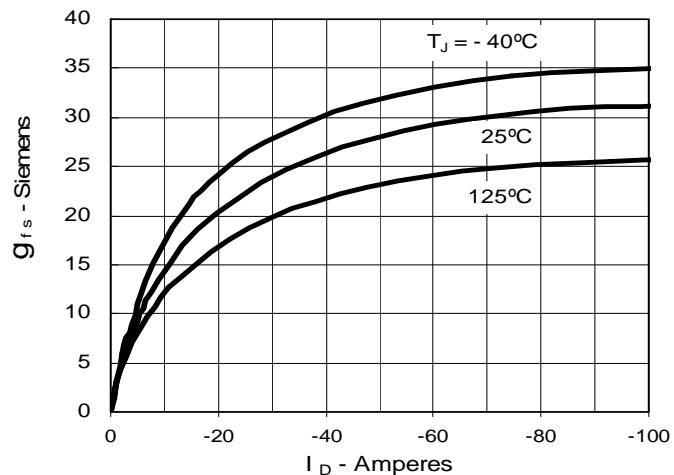


Fig. 10. Gate Charge

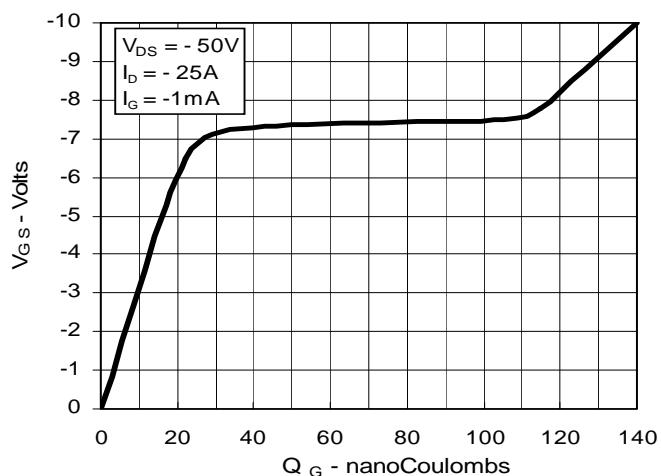
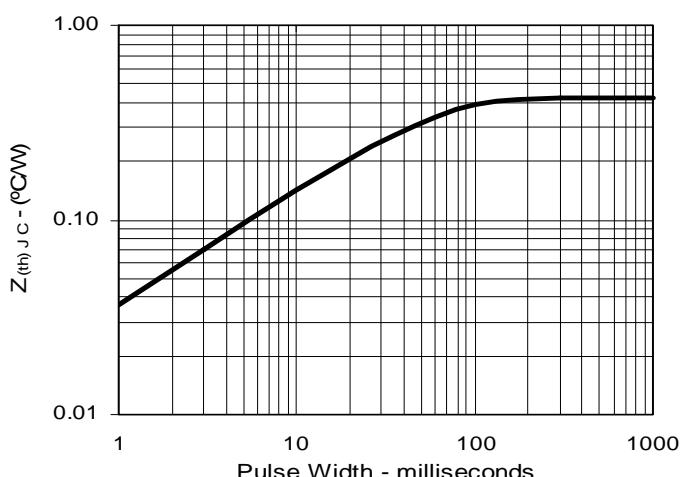


Fig. 12. Maximum Transient Thermal Impedance



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